**Absolute Maximum Ratings** ( $T_a=25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter		Value	Unit
$V_{DSS}$	Drain-Source Voltage		600	V
$I_D$	Drain Current	$T_c=25^\circ\text{C}$	18	A
		$T_c=100^\circ\text{C}$	11.5	
$V_{GSS}$	Gate - Source voltage		$\pm 30$	V
$E_{AS}$	Single Pulse Avalanche Energy (note1)		920	mJ
$I_{AR}$	Avalanche Current (note2)		18	A
$P_D$	Power Dissipation ( $T_c=25^\circ\text{C}$ )		60	W
$T_j$	Junction Temperature(Max)		150	$^\circ\text{C}$
$T_{stg}$	Storage Temperature		-55~+150	
$TL$	Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds		300	

**Thermal Characteristics**

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JC}$	Thermal Resistance,Junction to Case	-	2.08	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance,Junction to Ambient	-	62.5	

**Electrical Characteristics** (Ta=25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
<b>Off Characteristics</b>						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =250μA, V <sub>GS</sub> =0	600	-	-	V
△BV <sub>DSS</sub> /△T <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> =250μA, Reference to 25°C	-	0.71	-	V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V	-	-	10	μA
		V <sub>DS</sub> =480V, T <sub>c</sub> =125°C			100	
I <sub>GSSF</sub>	Gate-body leakage Current, Forward	V <sub>GS</sub> =+30V, V <sub>DS</sub> =0V	-	-	100	nA
I <sub>GSSR</sub>	Gate-body leakage Current, Reverse	V <sub>GS</sub> =-30V, V <sub>DS</sub> =0V	-	-	-100	
<b>On Characteristics</b>						
V <sub>GS(TH)</sub>	Date Threshold Voltage	I <sub>D</sub> =250μA, V <sub>DS</sub> =V <sub>GS</sub>	2	-	4	V
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	I <sub>D</sub> =7.5A, V <sub>GS</sub> =10V	-	0.45	0.52	Ω
<b>Dynamic Characteristics</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =25V, V <sub>GS</sub> =0, f=1.0MHz	-	2450	-	pF
C <sub>oss</sub>	Output Capacitance		-	295	-	
C <sub>rss</sub>	Reverse Transfer Capacitance		-	23.6	-	
<b>Switching Characteristics</b>						
T <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> =325V, I <sub>D</sub> =18A R <sub>G</sub> =21.7Ω (Note 3,4)	-	65	140	ns
T <sub>r</sub>	Turn-On Rise Time		-	125	260	
T <sub>d(off)</sub>	Turn-Off Delay Time		-	105	220	
T <sub>f</sub>	Turn-Off Rise Time		-	65	140	
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =480V, V <sub>GS</sub> =10V, I <sub>D</sub> =18A (Note 3,4)	-	48.5	63	nC
Q <sub>gs</sub>	Gate-Source Charge		-	14	-	
Q <sub>gd</sub>	Gate-Drain Charge		-	21	-	
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
I <sub>s</sub>	Max. Diode Forward Current	-	-	-	18	A
I <sub>SM</sub>	Max. Pulsed Forward Current	-	-	-	72	
V <sub>SD</sub>	Diode Forward Voltage	I <sub>D</sub> =18A	-	-	1.4	V
T <sub>rr</sub>	Reverse Recovery Time	I <sub>s</sub> =18A, V <sub>GS</sub> =0V diF/dt=100A/μs (Note3)	496	-	-	nS
Q <sub>rr</sub>	Reverse Recovery Charge		5.69	-	-	μC

Notes : 1, L=8.15mH, IAS=18A, VDD=50V, RG=25Ω, Starting TJ =25°C

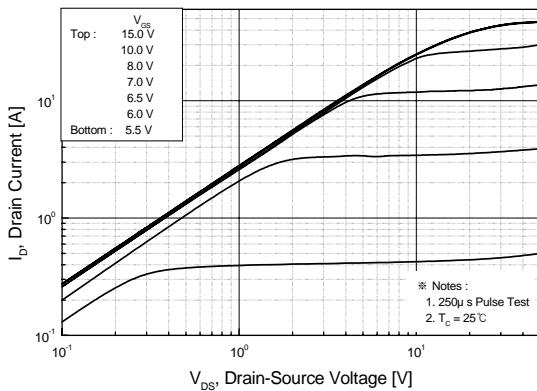
2, Repetitive Rating : Pulse width limited by maximum junction temperature

3, Pulse Test : Pulse Width ≤ 300μs, Duty Cycle ≤ 2%

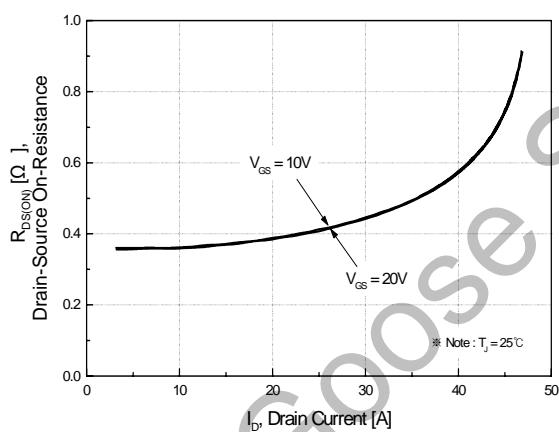
4, Essentially Independent of Operating Temperature

## Typical Characteristics

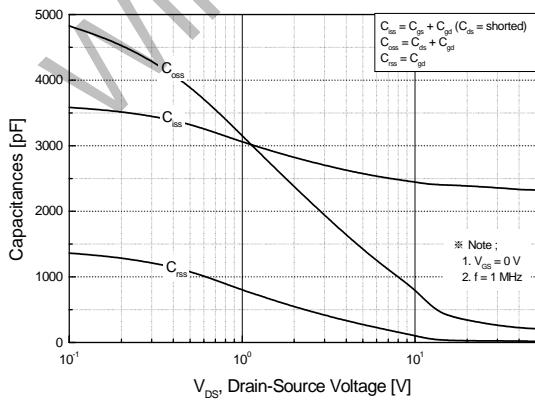
**Figure 1. On-Region Characteristics**



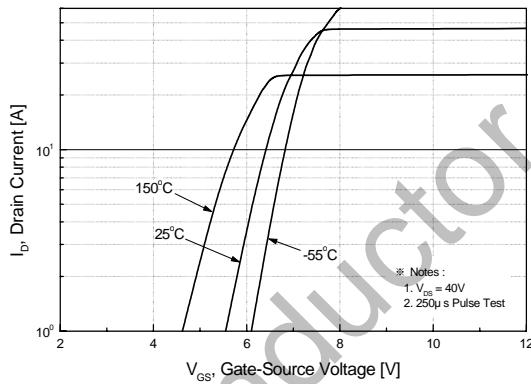
**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**



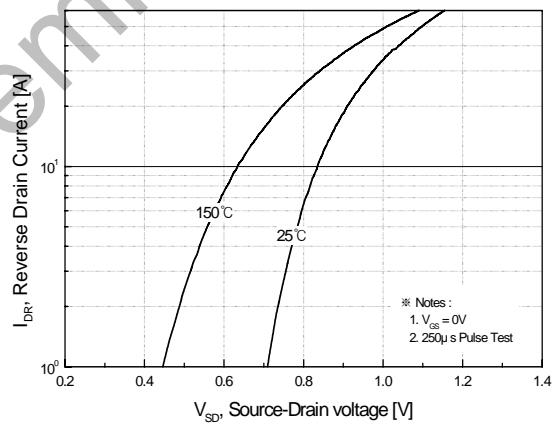
**Figure 5. Capacitance Characteristics**



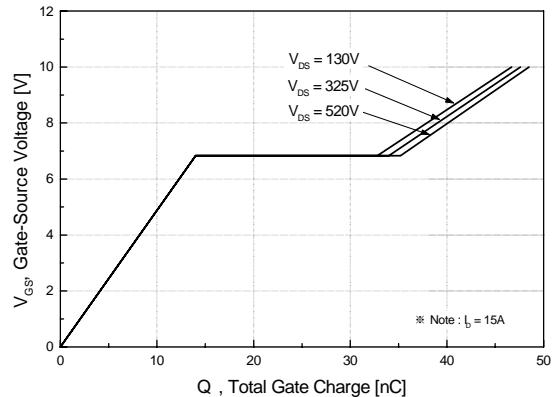
**Figure 2. Transfer Characteristics**

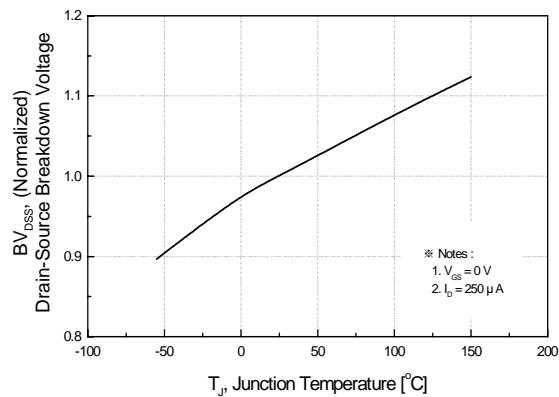
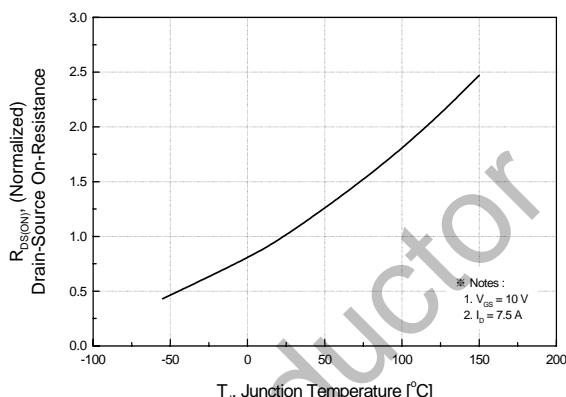
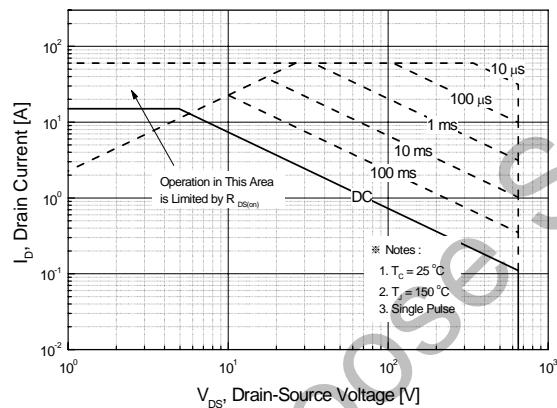
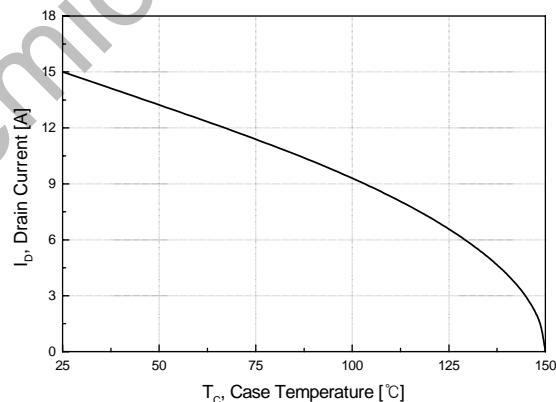
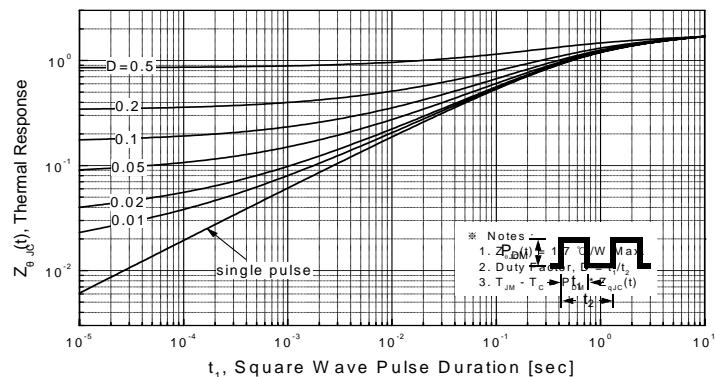


**Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature**

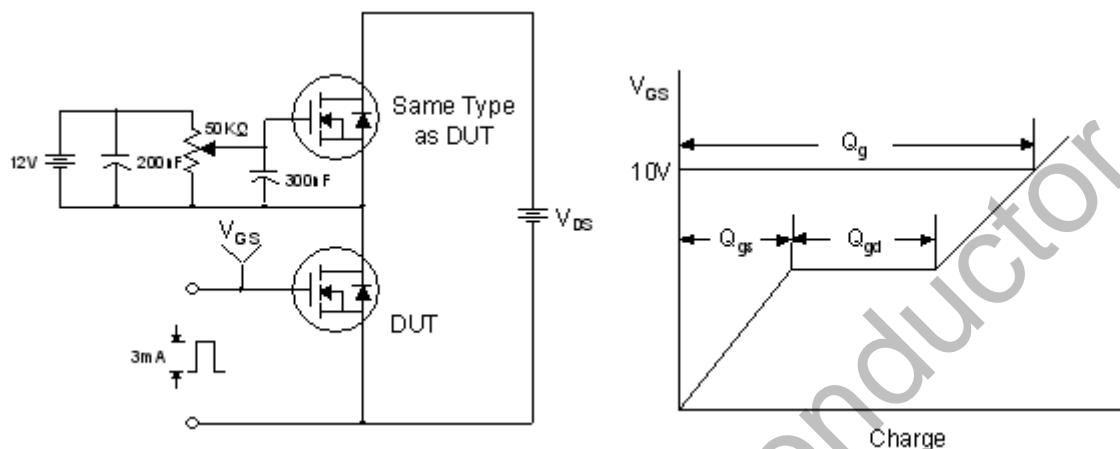


**Figure 6. Gate Charge Characteristics**

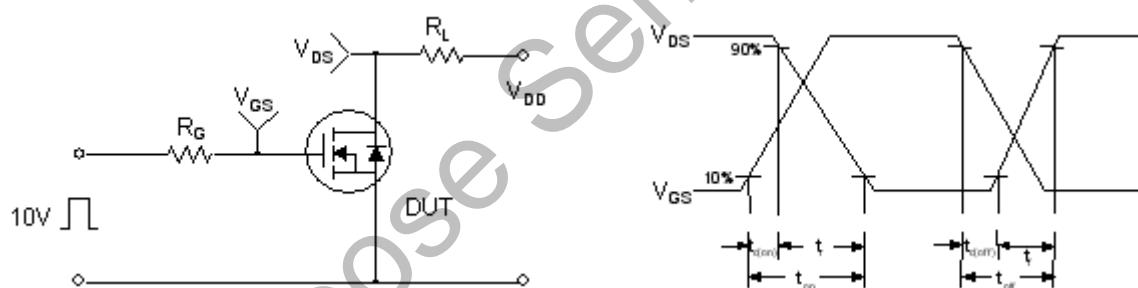


**Typical Characteristics** (Continued)**Figure 7. Breakdown Voltage Variation vs. Temperature****Figure 8. On-Resistance Variation vs. Temperature****Figure 9-2. Safe Operating Area****Figure 10. Maximum Drain Current vs. Case Temperature****Figure 11-2. Transient Thermal Response Curve**

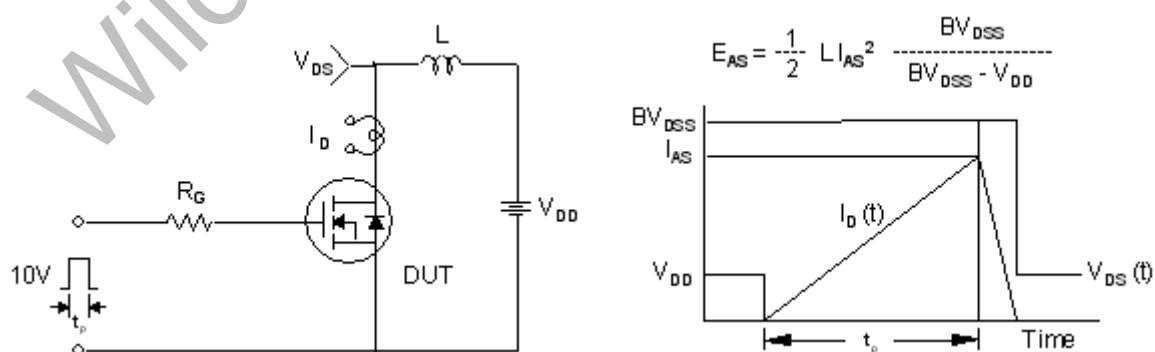
Gate Charge Test Circuit &amp; Waveform



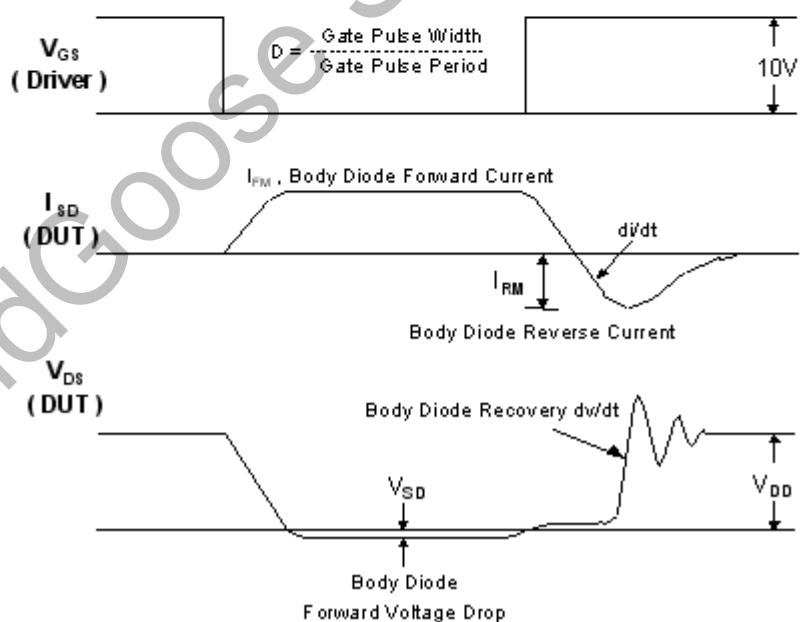
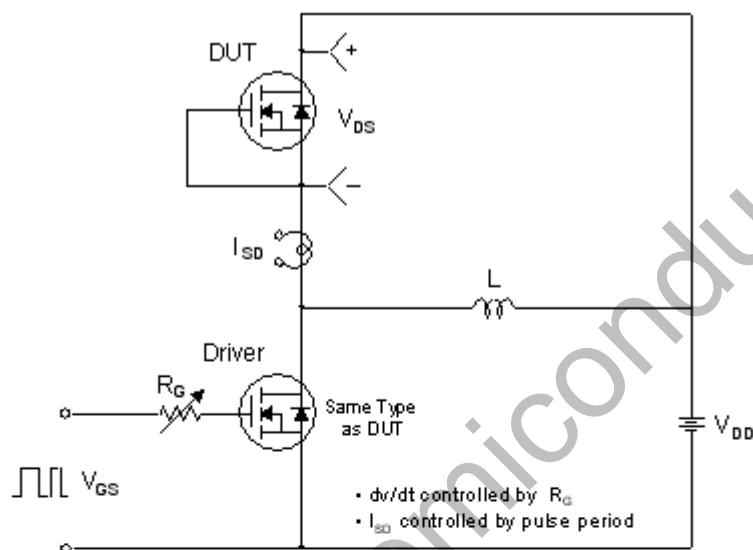
Resistive Switching Test Circuit &amp; Waveforms



Unclamped Inductive Switching Test Circuit &amp; Waveforms



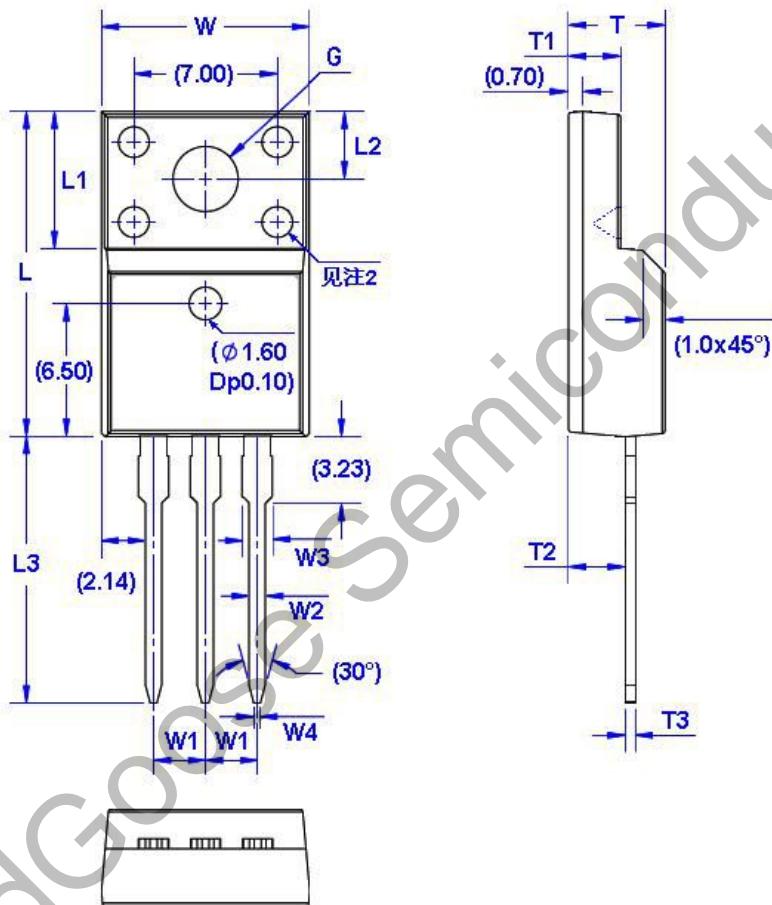
## Peak Diode Recovery dv/dt Test Circuit &amp; Waveforms



Package Dimension

TO-220F

Unit: mm



Symbol	Size		Symbol	Size		Symbol	Size		Symbol	Size	
	Min	Max		Min	Max		Min	Max		Min	Max
W	9.96	10.36	W4	0.25	0.45	L3	12.78	13.18	T3	0.45	0.60
W1	2.54 (TYP)		L	15.67	16.07	T	4.50	4.90	G(Φ)	3.08	3.28
W2	0.70	0.90	L1	6.48	6.88	T1	2.34	2.74			
W3	1.24	1.47	L2	3.20	3.40	T2	2.56	2.96			